## Notice of References Cited Application/Control No. O9/835,296 Examiner Son P. Huynh Applicant(s)/Patent Under Reexamination SANO ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0124252	09-2002	Schaefer et al.	725/33
*	В	US-2002/0049975	04-2002	Thomas et al.	725/60
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
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	j	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
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## **NON-PATENT DOCUMENTS**

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